Notice of References Cited Exeminer

Application/Control No. 10/620,716	Reexaminati	Applicant(s)/Patent Under Reexamination CHUNG ET AL.	
Examiner	Art Unit		
VIJAY SHANKAR	2673	Page 1 of 1	

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,624,857	09-2003	Nagata et al.	349/54
*	В	US-6,756,959	06-2004	Fujino, Hiroaki	345/95
*	С	US-6,388,652	05-2002	Yamazaki et al.	345/98
*	D	US-6,778,164 b2	08-2004	Yamazaki et al.	345/98
*	ш	US-2005/0017940 a1	01-2005	Yamazaki et al.	345/098
	F	US-	·		
	O	US-			
	Ξ	US-			
	_	US-			
	J	US-			
	K	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
L	0					
	Р					
	Q					
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	v	
	w	
	х	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.